P-Channel Enhancement Mode Field Effect Transistor NDT2955

General Description

This 60 V P-Channel MOSFET is produced using **onsemi**'s high voltage Trench process. It has been optimized for power management plications.

Features

- -2.5 A, -60 V
 - $R_{DS(ON)} = 300 \text{ m}\Omega @ V_{GS} = -10 \text{ V}$
 - $R_{DS(ON)} = 500 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
- High Density Cell Design for Extremely Low R_{DS(ON)}.
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- This is a Pb–Free Device

Applications

- DC/DC Converter
- Power Management

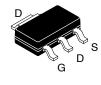
Symbol	Parameter	Value	Unit
V _{DSS}	Drain-Source Voltage	-60	V
V_{GSS}	Gate-Source Voltage	±20	V
I _D	Drain Current		А
	– Continuous (Note 1a)	-2.5	
	– Pulsed	-15	
PD	Maximum Power Dissipation		W
	(Note 1a)	3.0	
	(Note 1b)	1.3	
	(Note 1c)	1.1	
T _J , T _{STG}	Operating and Storage Temperature Range	–55 to +150	°C

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C, unless otherwise noted)

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

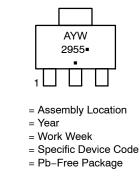
THERMAL CHARACTERISTICS (T_A = 25°C, unless otherwise noted)

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Symbol	Parameter	Мах	Unit	
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	42	°C/W	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case (Note 1)	12	°C/W	



SOT-223 CASE 318H-01

MARKING DIAGRAM



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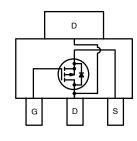
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(Note: Microdot may be in either location)

PINOUT DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping [†]
NDT2955	SOT-223 (Pb-Free)	4000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <u>BRD8011/D</u>.

NDT2955

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
VALANCHE	ERATINGS			-		
W _{DSS}	Drain-Source Avalanche Energy	Single Pulse, V_{DD} = 30 V, I_D = 2.5 A	_	-	174	mJ
FF CHARA	CTERISTICS					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0~V,~I_D=-250~\mu A$	-60	-	-	V
$\frac{\Delta \text{BV}_{\text{DSS}}}{\Delta \text{T}_{\text{J}}}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C	_	-60	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = -60 V, V _{GS} = 0 V	_	-	-10	μA
I _{GSSF}	Gate-Body Leakage, Forward	V _{GS} = -20 V, V _{DS} = 0 V	-	_	100	nA
I _{GSSR}	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$	-	_	-100	nA
N CHARAC	CTERISTICS (Note 2)			•		
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250 \ \mu A$	-2	-2.6	-4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{J}}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C	-	5.7	-	mV/°C
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -10$ V, $I_D = -2.5$ A	_	95	300	mΩ
		$V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -2 \text{ A}$	-	163	500	
		V_{GS} = -10 V, I _D = -2.5 A, T _J = 125°C	-	153	513	
I _{D(ON)}	On-State Drain Current	$V_{GS} = -10$ V, $V_{DS} = -5$ V	-12	-	-	Α
9 _{FS}	Forward Transconductance	V _{DS} = -10 V, I _D = -2.5 A	-	5.5	-	S
YNAMIC CI	HARACTERISTICS					
C _{iss}	Input Capacitance	V_{DS} = –30 V, V_{GS} = 0 V, f = 1.0 MHz	_	601	-	pF
C _{oss}	Output Capacitance		-	85	-	pF
C _{rss}	Reverse Transfer Capacitance		-	35	-	pF
WITCHING	CHARACTERISTICS (Note 2)					
t _{d(on)}	Turn – On Delay Time	V_{DD} = -30 V, I_D = -1 A, V_{GS} = -10 V, R_{GEN} = 6 Ω	_	12	21	ns
t _r	Turn – On Rise Time	$V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$	-	10	20	ns
t _{d(off)}	Turn – Off Delay Time		_	19	34	ns
t _f	Turn – Off Fall Time	1	-	6	12	ns
Qg	Total Gate Charge	V_{DS} = –30 V, I_{D} = –2.5 A, V_{GS} = –10 V	-	11	15	nC
Q _{gs}	Gate-Source Charge	1	-	2.4	-	nC
Q _{gd}	Gate-Drain Charge		-	2.7	_	nC
	RCE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS				
I _S	Maximum Continuous Drain-Source Dio	de Forward Current	-	-	-2.5	А
V _{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{S} = -2.5 \text{ A} \text{ (Note 2)}$	-	-0.8	-1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = -2.5 \text{ A},$ $d_{iF}/d_t = 100 \text{ A}/\mu \text{s}$	-	25	-	ns
Q _{rr}	Diode Reverse Recovery Charge		-	40	-	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 42°C/W when mounted on a 1 in^2 pad of 2 oz copper.



b. 95°C/W when mounted on a 0.066 \mbox{in}^2 pad of 2 oz copper.

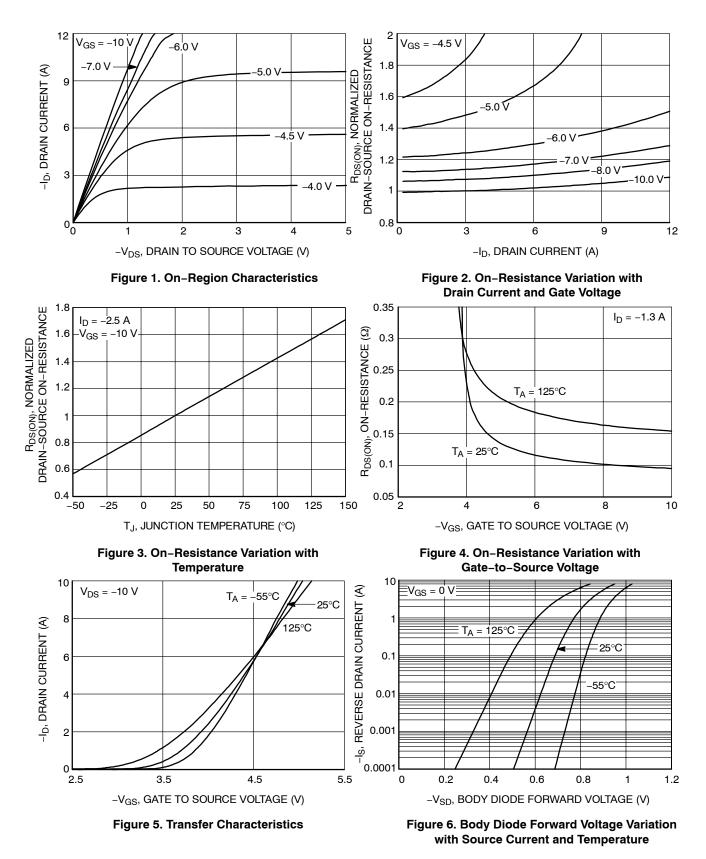
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c. 110°C/W when mounted on a minimum pad.

2. Pulse Test: Pulse Width < 300 µs, Duty Cycle < 2.0%.

NDT2955

TYPICAL CHARACTERISTICS



SOT-223 CASE 318H ISSUE B DATE 13 MAY 2020 A NDTES SCALE 2:1 DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009. CONTROLLING DIMENSION: MILLIMETERS DIMENSIONS D & E1 ARE DETERMINED AT DATUM H. DIMENSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS DO NOT INCLUDE MOLD FLASH, PROTRUSIONS DO RGATE BURRS. SHALL NOT EXCEED 0.23mm PER SIDE. LEAD DIMENSIONS & AND b1 DO NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBBAR PROTRUSION IS 0.08mm PER SIDE. DATUMS A AND B ARE DETERMINED AT DATUM H. A1 IS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS & AND b1. DIMENSIONING AND TOLERANCING PER ASME 1. b1 2 з. В 4. 5. 6. 7. b AND b1. MILLIMETERS DIM MIN. NITM. MAX. e ___ ___ 1.80 k Α \oplus 0.10 \otimes C A B 0.02 0.06 0.11 A1 TOP VIEW NDTE 7 0.60 0.74 0.88 b 2.90 3.10 b1 3.00 DETAIL A 0.24 ____ 0.35 С H 6.70 D 6.30 6.50 Ε 6.70 7.00 7.30 E1 3.30 3.50 3.70 0.10 C 2.30 BSC e SIDE VIEW FND VIEW L 0.25 ___ i 10° 0° ____ -3.80 2.00 Α1 DETAIL A 8.30 3x= Assembly Location GENERIC A 2.00 **MARKING DIAGRAM*** Y = Year = Work Week w XXXXX = Specific Device Code = Pb-Free Package 5'30 AYW 3x 1.50 (Note: Microdot may be in either location) XXXXX= PITCH *This information is generic. Please refer to RECOMMENDED MOUNTING FOOTPRINT device data sheet for actual part marking. For additional information on our Pb-Free strategy Pb-Free indicator, "G" or microdot "•", may ж and soldering details, please download the DN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D. or may not be present. Some products may not follow the Generic Marking. Electronic versions are uncontrolled except when accessed directly from the Document Repository. **DOCUMENT NUMBER:** 98ASH70634A Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red. **DESCRIPTION:** SOT-223 PAGE 1 OF 1

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